

150V, 100A N-CHANNEL POWER MOSFET**GENERAL DESCRIPTION**

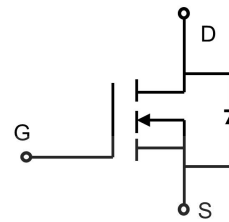
The SGP157R5T uses advanced SGT technology and design to provide excellent $R_{DS(on)}$ with low gate charge. It can be used in a wide variety applications.

Features

- ◆ $V_{DS}=150V$, $I_D=100A$
- ◆ $R_{DS(on)}$
TYP: $6.2m\Omega$ @ $V_{GS}=10V$

Applications

- ◆ Power factor correction (PFC)
- ◆ Switched mode power supplies (SMPS)
- ◆ Uninterruptible power supply (UPS)
- ◆ LED lighting power

**ORDERING INFORMATION**

Part No.	Package	Marking	Material	Packing
SGP157R5T	TO-220-3L	SGP157R5T	Pb Free	Tube

ABSOLUTE MAXIMUM RATINGS (T_J=25°C unless otherwise noted)

Characteristics	Symbol	Ratings	Unit
Drain-Source Voltage	V _{DS}	150	V
Gate-Source Voltage	V _{GS}	±20	V
Drain Current	I _D	T _C = 25°C	A
		T _C = 100°C	
Drain Current Pulsed(Note 1)	I _{DM}	400	A
Power Dissipation(T _C =25°C) -Derate above 25°C	P _D	262	W
Single Pulsed Avalanche Energy (Note 2)	E _{AS}	1406	mJ
Operation Junction Temperature Range	T _J	-55~+150	°C
Storage Temperature Range	T _{stg}	-55~+150	°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	TL	300	°C

THERMAL CHARACTERISTICS

Characteristics	Symbol	MAX	Unit
Thermal Resistance, Junction-to-Case	R _{θJC}	0.48	°C/W
Thermal Resistance, Junction-to-Ambient	R _{θJA}	62.5	°C/W

ELECTRICAL CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max	Unit
Off Characteristics						
Drain -Source Breakdown Voltage	B _V DSS	V _{GS} =0V, I _D =250μA	150	--	--	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =150V, V _{GS} =0V	--	--	1	uA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =20V, V _{DS} =0V	--	--	100	nA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =-20V, V _{DS} =0V	--	--	-100	
On Characteristics						
Gate Threshold Voltage	V _{GS(th)}	V _{GS} = V _{DS} , I _D =250μA	2.2	3.2	3.8	V
Static Drain- Source On State Resistance	R _{DS(on)}	V _{GS} =10V, I _D =50A	--	6.2	7.5	mΩ
Dynamic Characteristics						
Gate Resistance	R _g	V _{GS} =0V, f=1.0MHZ	--	4.2	--	Ω
Input Capacitance	C _{iss}	V _{DS} =75V V _{GS} =0V f=1.0MHZ	--	4620	--	pF
Output Capacitance	C _{oss}		--	950	--	
Reverse Transfer Capacitance	C _{rss}		--	15	--	
Switching Characteristics						
Turn-on Delay Time	t _{d(on)}	V _{DD} =50V, V _{DS} =10V R _G =1.6Ω, I _D =50A (Note 3.4)	--	23.5	--	ns
Turn-on Rise Time	t _r		--	46.1	--	
Turn-off Delay Time	t _{d(off)}		--	62.3	--	
Turn-off Fall Time	t _f		--	19.8	--	

Total Gate Charge	Q_g	$V_{DS}=75V, I_D=50A$ $V_{GS}=10V$ (Note 3.4)	--	73.6	--	nC
Gate-Source Charge	Q_{gs}		--	35.1	--	
Gate-Drain Charge	Q_{gd}		--	14.2	--	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	I_S	Integral Reverse P-N Junction Diode in the MOSFET	--	--	100	A
Pulsed Source Current	I_{SM}		--	--	400	
Diode Forward Voltage	V_{SD}	$I_S=50A, V_{GS}=0V$	--	0.85	1.4	V
Reverse Recovery Time	T_{rr}	$I_F=50A, V_R=10V,$ $dI_F/dt=100A/\mu S$	--	125	--	ns
Reverse Recovery Charge	Q_{rr}		--	408	--	nC

1. Pulse width limited by maximum junction temperature

2. $L=0.5mH, V_{DD}=100V, R_G=25\Omega$, starting $T_J=25^\circ C$

3. Pulse Test: Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$

4. Essentially independent of operating temperature

Typical Performance Characteristics

Figure 1. Output Characteristics

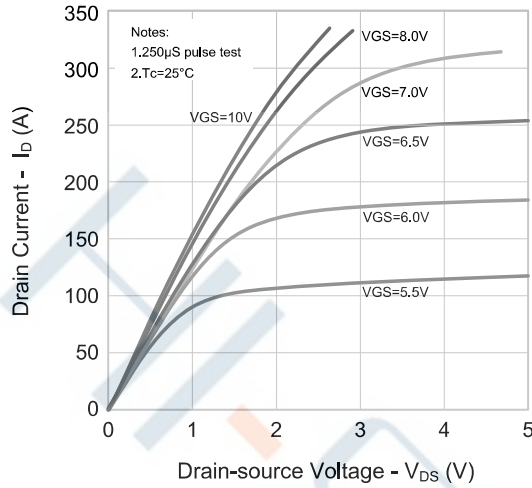


Figure 2. Transfer Characteristics

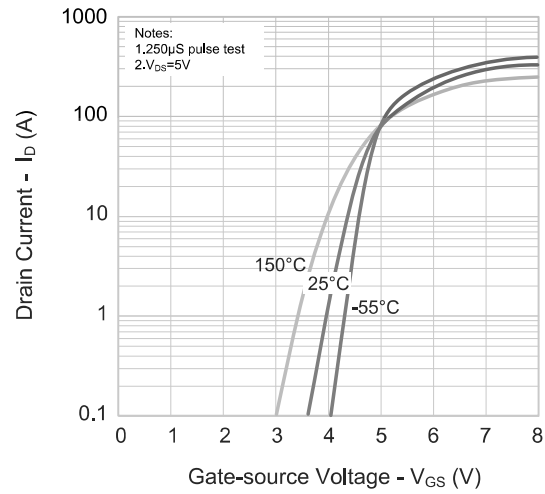


Figure 3. On-resistance vs. Drain Current

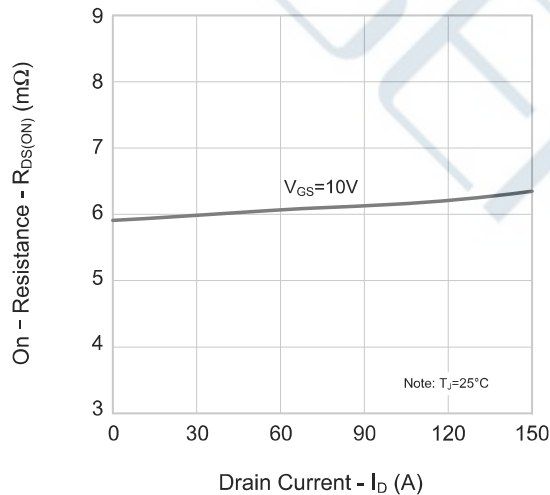


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

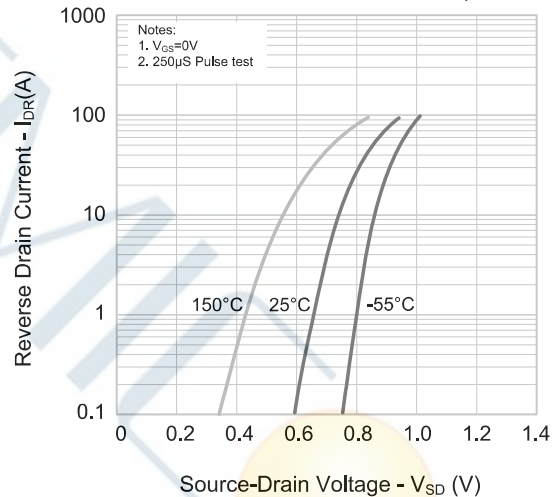


Figure 5. Capacitance Characteristics

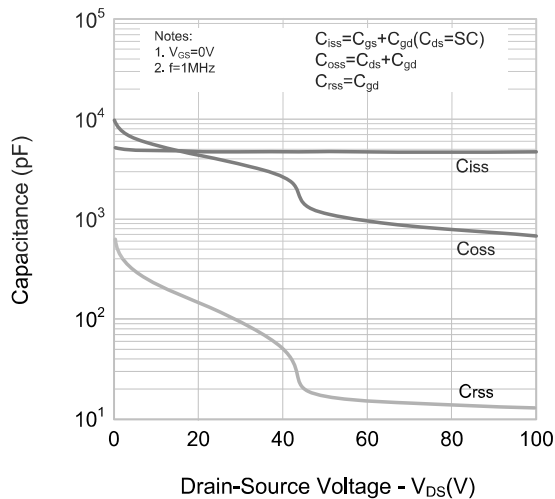
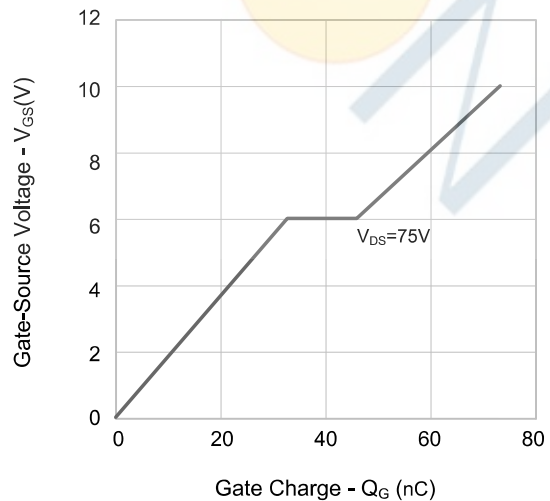


Figure 6. Gate Charge



Typical Performance Characteristics

Figure 7. Breakdown Voltage vs. Temperature Characteristics

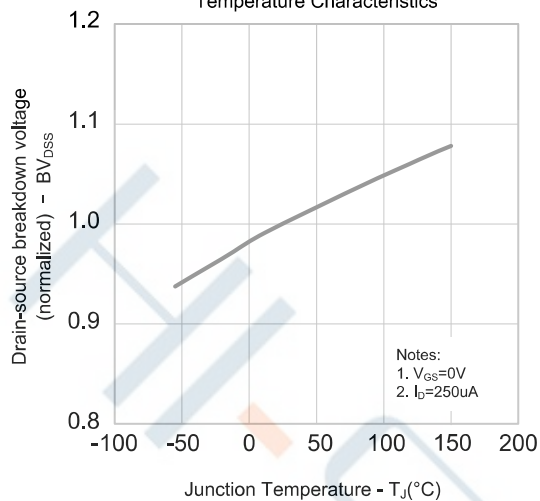


Figure 8. On-resistance vs. Temperature Characteristics

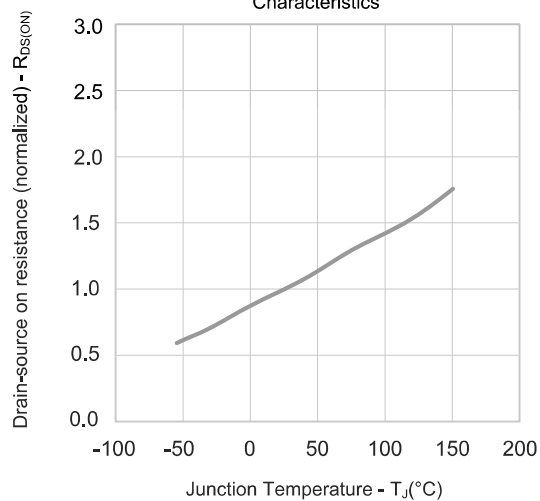
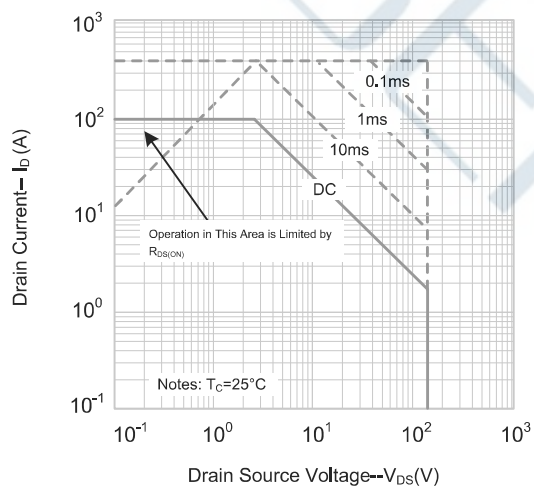
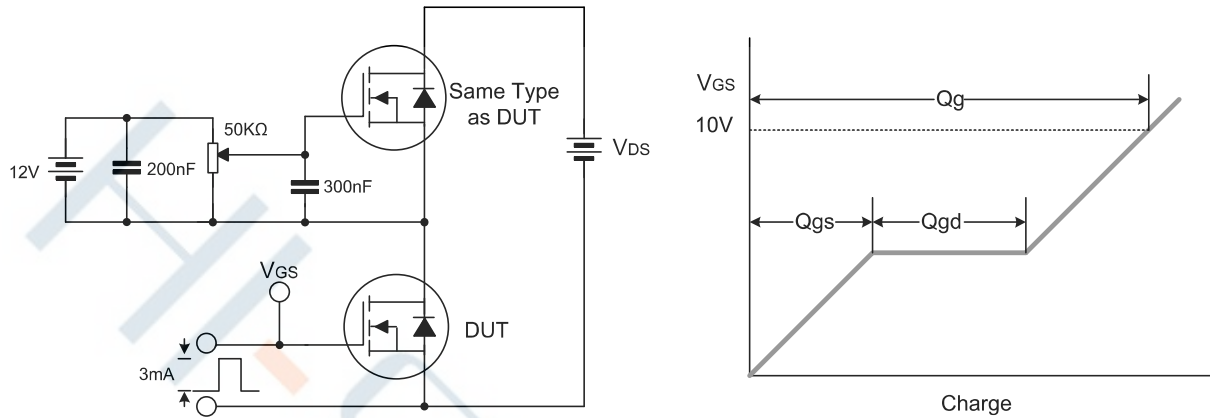


Figure 9. Max. Safe Operating Area

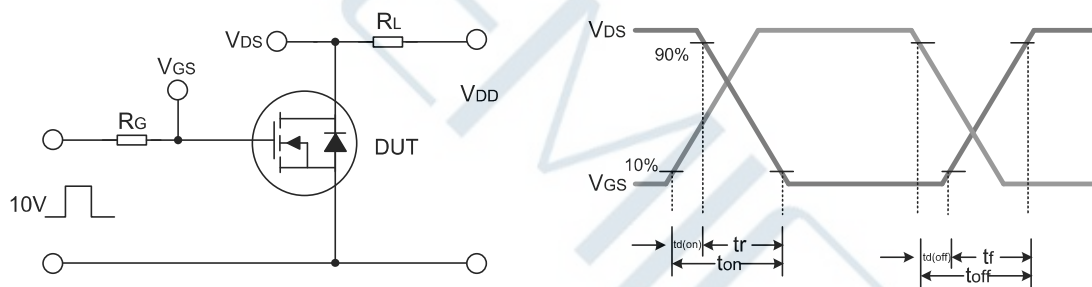


Test Circuit

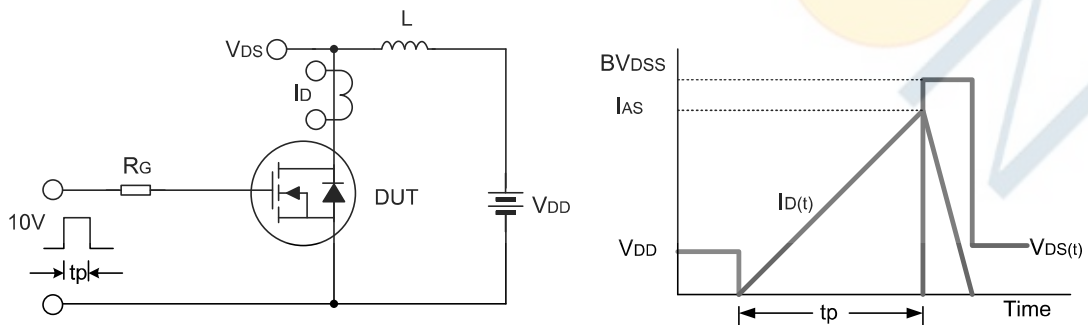
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform

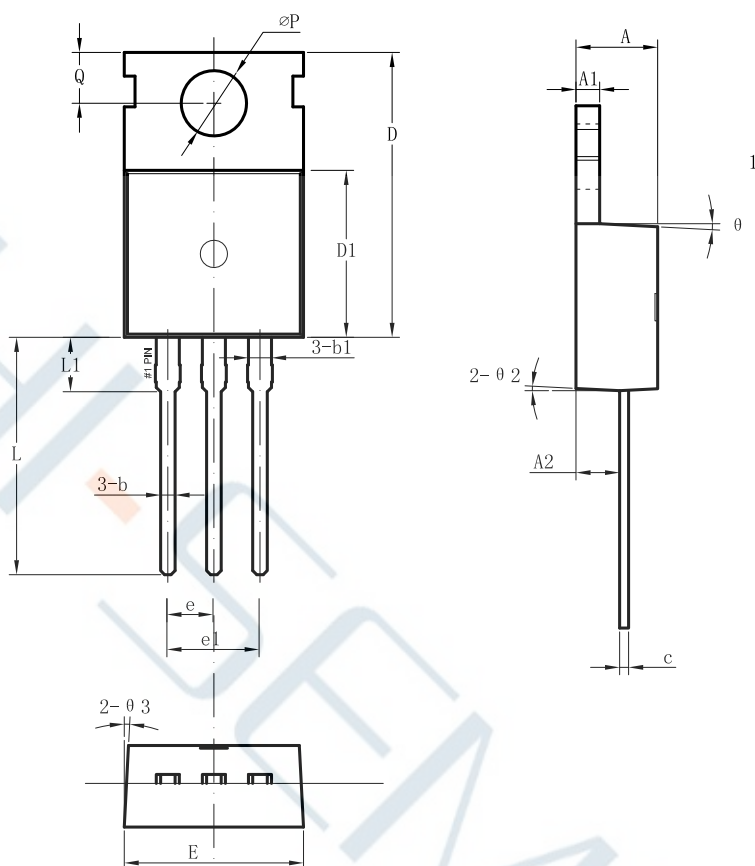


Unclamped Inductive Switching Test Circuit & Waveform



Package Dimensions of TO-220-3L

Unit:mm



符号	机械尺寸/mm		
	最小值	典型值	最大值
A	4.30	4.50	4.70
A1	1.25	1.30	1.40
A2	2.20	2.40	2.60
b	0.70	0.80	0.95
b1		1.27	
c	0.40	0.50	0.65
D	15.20	15.70	16.20
D1	9.00	9.20	9.40
E	9.70	10.0	10.10
e		2.54	
e1		5.08	
L	12.60	13.08	13.60
L1		3.00	
φ P	3.50	3.60	3.80
Q	2.60	2.80	3.00
θ1		3°	
θ2		3°	
θ3		3°	

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